## Applicant(s)/Patent Under Application/Control No. Reexamination LEE, JU-HEON 09/685,138 Notice of References Cited Art Unit Examiner Page 1 of 1 2182 Kim Huynh

## U.S. PATENT DOCUMENTS

U.S. PATENT DOCUMENTS						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
	A	US-6,012,103	01-2000	Sartore et al.	710/8	
$\vdash$	В	US-6,061,791	05-2000	Moreau, Thierry	713/171	
	c	US-6,058,441	05-2000	Shu, Han	710/100	
	D	US-				
	Е	US-				
	F	US-				
	G	US-				
	Н	US-				
	1	US-				
	J	US-				
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	FOREIGN PATENT DOCUMENTS					

## FOREIGN PATENT DOCUMENTS

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## **NON-PATENT DOCUMENTS**

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.